# Part Defect Traveler

**CASE:** C295025
**PART REQ:** RQ152896-1

**CASE OPEN:** 02-09-202
**PART REQ OPEN:** 02-09-2021

**Case Part:** 210000847 **Rev:** **Qty:** 1 **Serial Num:** 1908A01762
**Part Req Part:** 210000847 **Rev:** **Qty:** 1 **Serial Num:** 1908A01762
**Part Description:** LVPS AC/DC 30KW 250V SINGLE
**Analyst:** DAVIS AMETEK PROGRAMMABLE **Axcelis PO:**
**Part Lifetime:** 90 Days to 1 Year
**Symptom Code:** Any other reason

RGA# 100938

**Contamination:** Not Contaminated

**Executive Summary**
1. Action Replaced FEM power supply cause of high temp. Parent Case C292720 Summary: Occured FEM power supply error on gui alarm with FEM Current 0A We found tripped CB14 on HEB PD and tempreture was high 1 test : Turn on As 11MeV for 1hour -> 80deg on CB14 2 test : Turn on As 11MeV for 1hour with open PD door -> 60deg

**Case Originator:** MinSeok Kim
**Case Status:** New

SAMSUNG S4
**Case Owner:** MinSeok Kim

**Customer Severity:** Concerned
**Customer Impact:** Efficiency Loss
**Customer Expectation:**

**CRF:** No
**Customer Exp. Date:** ?/?/????

**Parent Case:** C292720 - OXE/Purion XE-135:-Final Energy Magnet-Controllers/Electronics-Other,Hardware:Circuit breaker in scan PD tempreature is high

**Responsible Site**
**Type:** **ID:** **Name:**
**Cause Code:** -

**Part Req Originator:** MinSeok Kim
**Part Req Status:** Awaiting Confirmation

**Part Req Site:** SAMSUNG ELECTRONICS CO, LTD Gyenggi-do South Korea
**Part Req Owner:** TaeWook Ko

**Case Solution**

| | Yes | No |
|---|---|---|
| **Replacement Required?** | ○ | ◉ |
| **Replacement Issued?** | ○ | ○ |
| **Back Ordered?** | ○ | ○ |
| **Work Order:** | | |

| Move To Loc/Disp | Date | Init | Comments |
|---|---|---|---|
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**Case History**
*** PHONE LOG 2021-02-09 ¿¿ 3:00:55 t4300578 Action Type: Incoming call

1. Action
Replaced FEM power supply cause of high temp.

Parent Case C292720 Summary:
Occured FEM power supply error on gui alarm with FEM Current 0A
We found tripped CB14 on HEB PD and tempreture was high
1 test : Turn on As 11MeV for 1hour -> 80deg on CB14
2 test : Turn on As 11MeV for 1hour with open PD door -> 60deg